

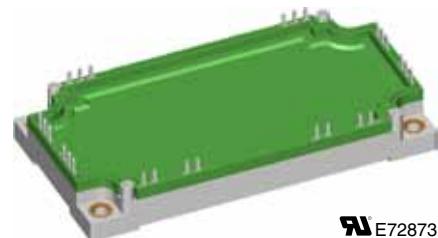
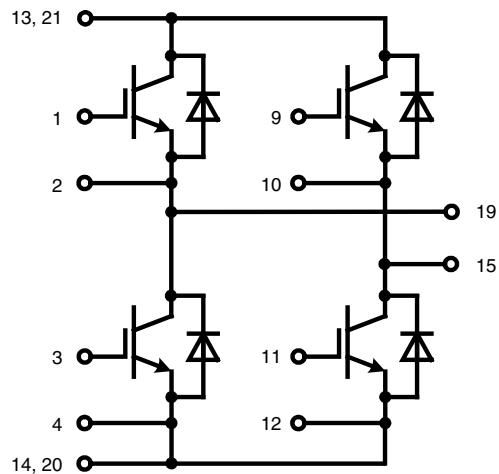
# IGBT Module

## H Bridge

$V_{CES} = 1200\text{ V}$   
 $I_{C25} = 120\text{ A}$   
 $V_{CE(sat)} = 1.8\text{ V}$

**Part name** (Marking on product)

MIXA81H1200EH



E72873

### Features:

- Easy paralleling due to the positive temperature coefficient of the on-state voltage
- Rugged XPT design  
(Xtreme light Punch Through) results in:
  - short circuit rated for 10  $\mu\text{sec}$ .
  - very low gate charge
  - square RBSOA @ 3x  $I_c$
  - low EMI
- Thin wafer technology combined with the XPT design results in a competitive low  $V_{CE(sat)}$
- SONIC™ diode
  - fast and soft reverse recovery
  - low operating forward voltage

### Application:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies

### Package:

- "E3-Pack" standard outline
- Insulated copper base plate
- Soldering pins for PCB mounting
- Optimizes pin layout

## Output Inverter T1 - T6

## Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
$V_{CES}$	collector emitter voltage	$T_{VJ} = 25^\circ C$		1200		V
$V_{GES}$	max. DC gate voltage	continuous		$\pm 20$		V
$V_{GEM}$	max. transient collector gate voltage	transient		$\pm 30$		V
$I_{C25}$	collector current	$T_C = 25^\circ C$		120		A
$I_{C80}$		$T_C = 80^\circ C$		84		A
$P_{tot}$	total power dissipation	$T_C = 25^\circ C$		390		W
$V_{CE(sat)}$	collector emitter saturation voltage	$I_C = 77 A; V_{GE} = 15 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	1.8 2.1	2.1	V
$V_{GE(th)}$	gate emitter threshold voltage	$I_C = 3 mA; V_{GE} = V_{CE}$	$T_{VJ} = 25^\circ C$	5.4	6.0	6.5
$I_{CES}$	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	0.03 0.6	0.2	mA mA
$I_{GES}$	gate emitter leakage current	$V_{GE} = \pm 20 V$			500	nA
$Q_{G(on)}$	total gate charge	$V_{CE} = 600 V; V_{GE} = 15 V; I_C = 75 A$		230		nC
$t_{d(on)}$	turn-on delay time	$V_{CE} = 600 V; I_C = 75 A$ $V_{GE} = \pm 15 V; R_G = 10 \Omega$	$T_{VJ} = 125^\circ C$	70		ns
$t_r$	current rise time			40		ns
$t_{d(off)}$	turn-off delay time			250		ns
$t_f$	current fall time			100		ns
$E_{on}$	turn-on energy per pulse			6.8		mJ
$E_{off}$	turn-off energy per pulse			8.3		mJ
<b>RBSOA</b>	reverse bias safe operating area	$V_{GE} = \pm 15 V; R_G = 10 \Omega;$	$T_{VJ} = 125^\circ C$ $V_{CEK} = 1200 V$		225	A
<b>SCSOA</b>	short circuit safe operating area					
$t_{sc}$	short circuit duration	$V_{CE} = 900 V; V_{GE} = \pm 15 V;$	$T_{VJ} = 125^\circ C$		10	$\mu s$
$I_{sc}$	short circuit current	$R_G = 10 \Omega$ ; non-repetitive		300		A
$R_{thJC}$	thermal resistance junction to case	(per IGBT)			0.32	K/W

## Output Inverter D1 - D6

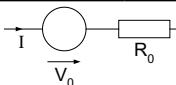
## Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
$V_{RRM}$	max. repetitive reverse voltage	$T_{VJ} = 25^\circ C$		1200		V
$I_{F25}$	forward current	$T_C = 25^\circ C$		135		A
$I_{F80}$		$T_C = 80^\circ C$		90		A
$V_F$	forward voltage	$I_F = 100 A; V_{GE} = 0 V$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	1.95 1.95	2.2	V V
$Q_{rr}$	reverse recovery charge	$V_R = 600 V$ $di_F/dt = -1600 A/\mu s$ $I_F = 100 A; V_{GE} = 0 V$	$T_{VJ} = 125^\circ C$	12.5		$\mu C$
$I_{RM}$	max. reverse recovery current			100		A
$t_{rr}$	reverse recovery time			350		ns
$E_{rec}$	reverse recovery energy			4		mJ
$R_{thJC}$	thermal resistance junction to case	(per diode)			0.4	K/W

 $T_C = 25^\circ C$  unless otherwise stated

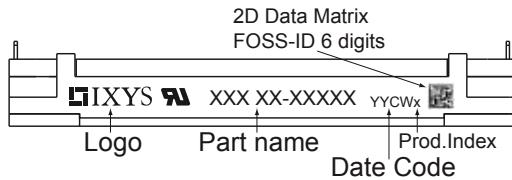
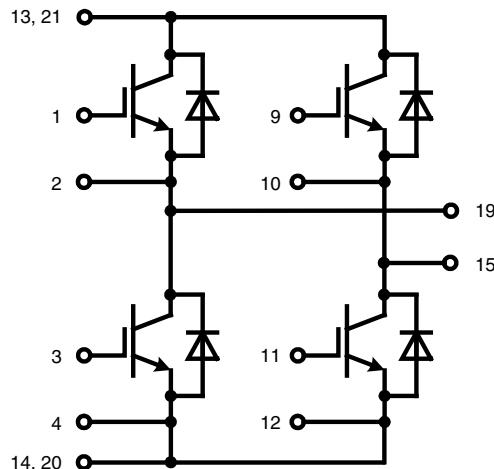
**Module**

<b>Symbol</b>	<b>Definitions</b>	<b>Conditions</b>	<b>Ratings</b>		
			<b>min.</b>	<b>typ.</b>	<b>max.</b>
$T_{VJ}$	<i>operating temperature</i>		-40		125
$T_{VJM}$	<i>max. virtual junction temperature</i>				150
$T_{stg}$	<i>storage temperature</i>		-40		125
$V_{ISOL}$	<i>isolation voltage</i>	$I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$			3000
<b>CTI</b>	<i>comparative tracking index</i>				200
$M_d$	<i>mounting torque (M5)</i>		3		6
$d_s$	<i>creep distance on surface</i>		10		mm
$d_A$	<i>strike distance through air</i>		7.5		mm
$R_{pin-chip}$	<i>resistance pin to chip</i>			2.5	$\text{m}\Omega$
$R_{thCH}$	<i>thermal resistance case to heatsink</i>	with heatsink compound		0.02	K/W
<b>Weight</b>				300	g

**Equivalent Circuits for Simulation**

<b>Symbol</b>	<b>Definitions</b>	<b>Conditions</b>	<b>Ratings</b>		
			<b>min.</b>	<b>typ.</b>	<b>max.</b>
$V_0$	<i>IGBT</i>	T1 - T6	$T_{VJ} = 150^\circ\text{C}$	1.1	V
$R_0$				17.9	$\text{m}\Omega$
$V_0$	<i>free wheeling diode</i>	D1 - D6	$T_{VJ} = 150^\circ\text{C}$	1.09	V
$R_0$				9.1	$\text{m}\Omega$

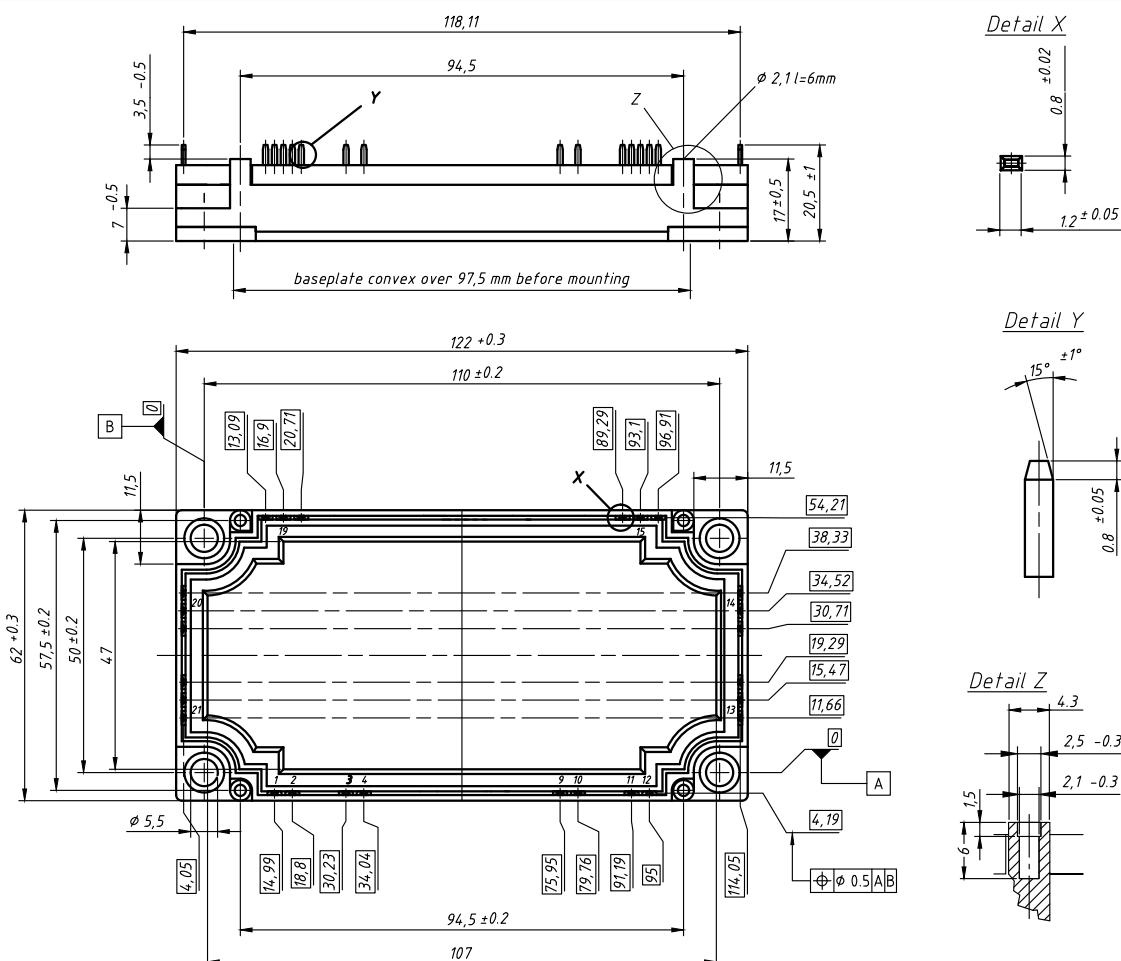
$T_C = 25^\circ\text{C}$  unless otherwise stated

**Circuit Diagram****Part number**

M = Module  
I = IGBT  
X = XPT  
A = standard  
81 = Current Rating [A]  
H = H~ Bridge  
1200 = Reverse Voltage [V]  
EH = E3-Pack

**Outline Drawing**

Dimensions in mm (1 mm = 0.0394")



*Remark:*  
Dimensions without tolerances acc. DIN ISO 2768-T1-m

**Product Marking**

Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MIXA 81 H 1200 EH	MIXA81H1200EH	Box	5	511053

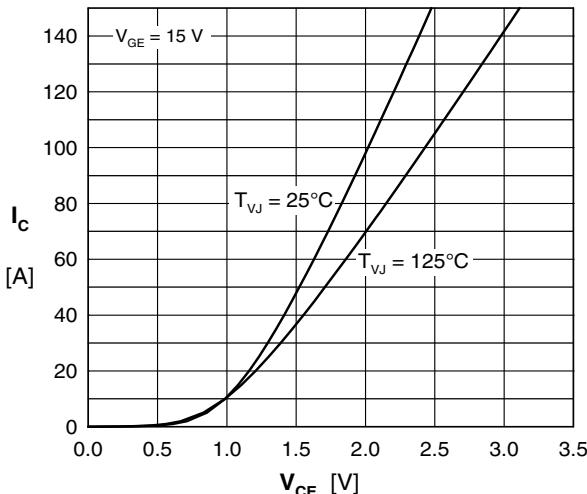
**Transistor T1 - T6**


Fig. 1 Typ. output characteristics

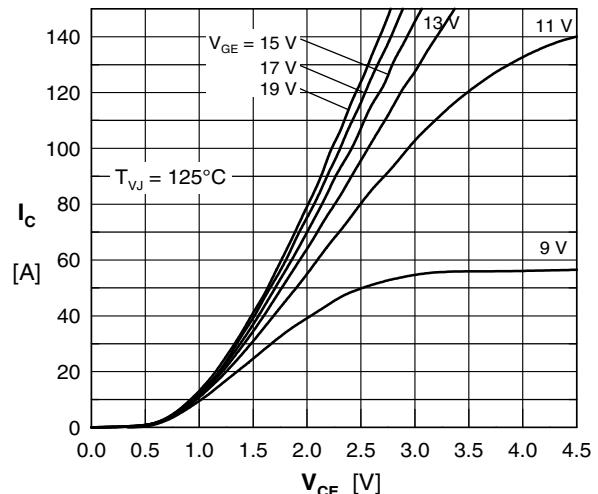


Fig. 2 Typ. output characteristics

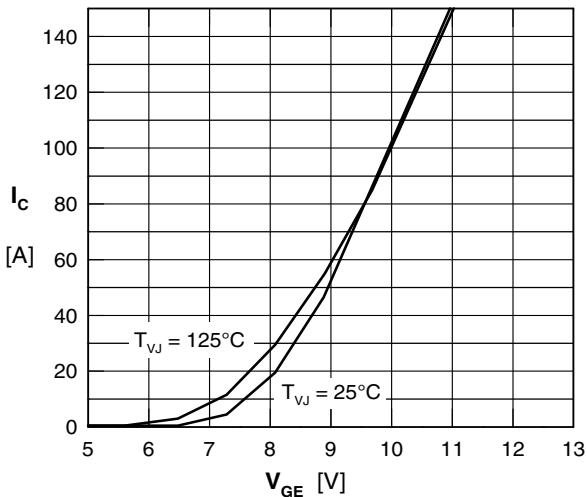


Fig. 3 Typ. tranfer characteristics

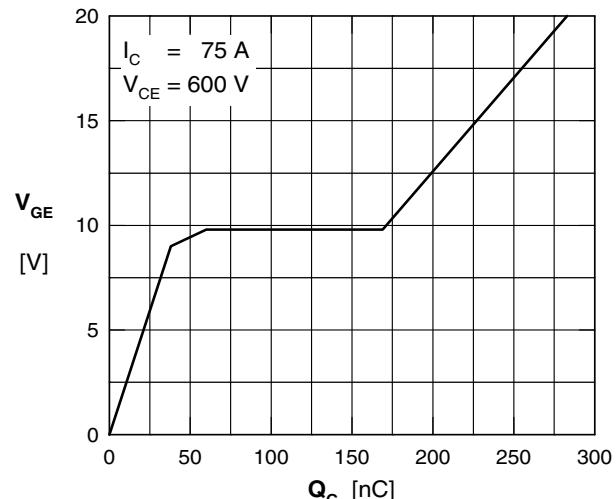


Fig. 4 Typ. turn-on gate charge

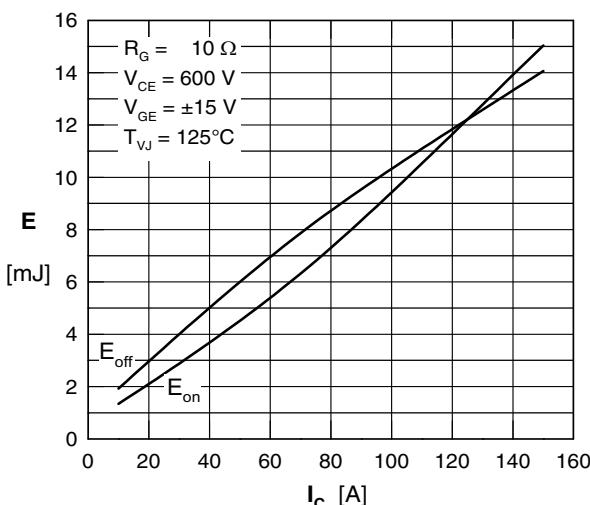


Fig. 5 Typ. switching energy vs. collector current

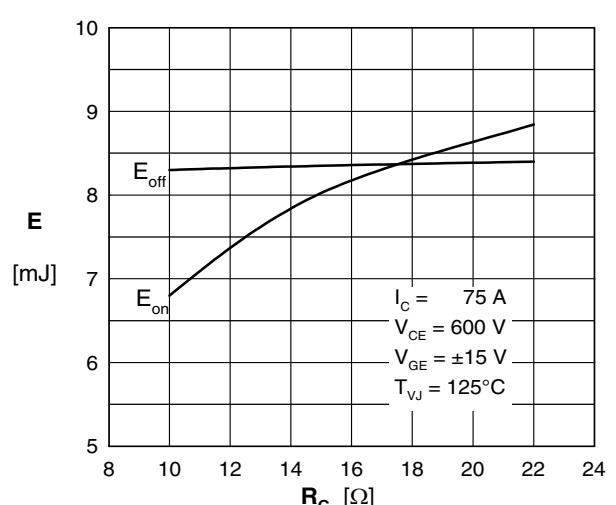


Fig. 6 Typ. switching energy vs. gate resistance

IXYS reserves the right to change limits, test conditions and dimensions.

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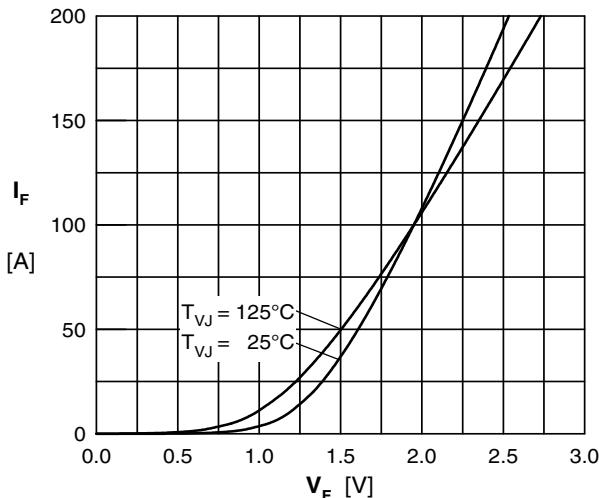
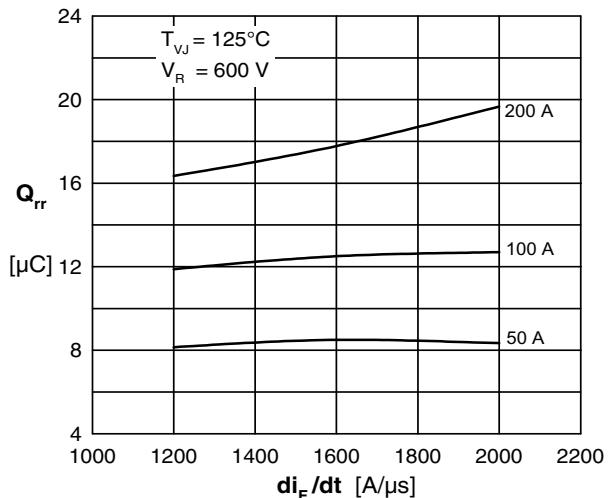
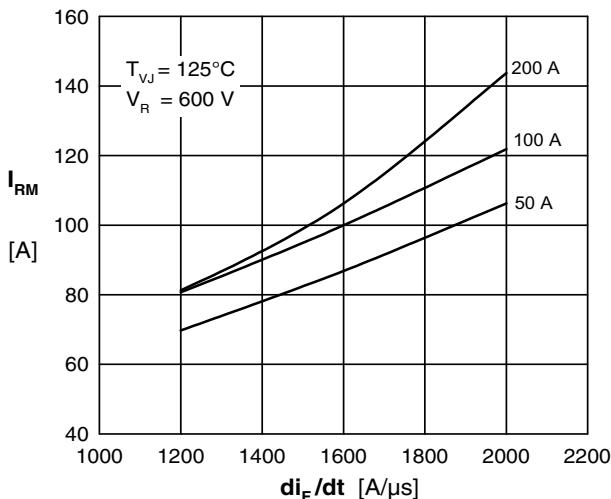
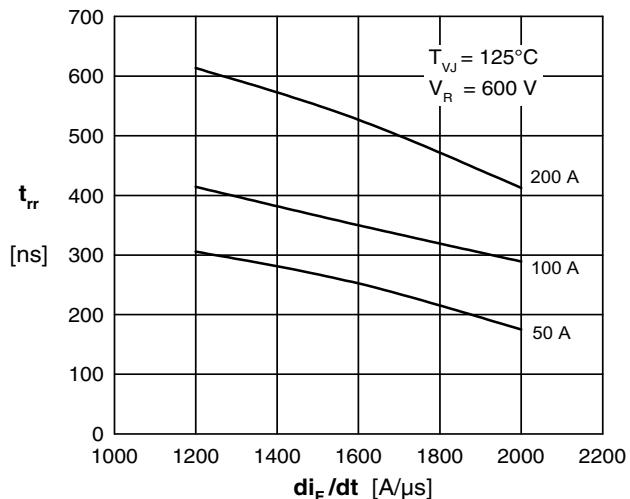
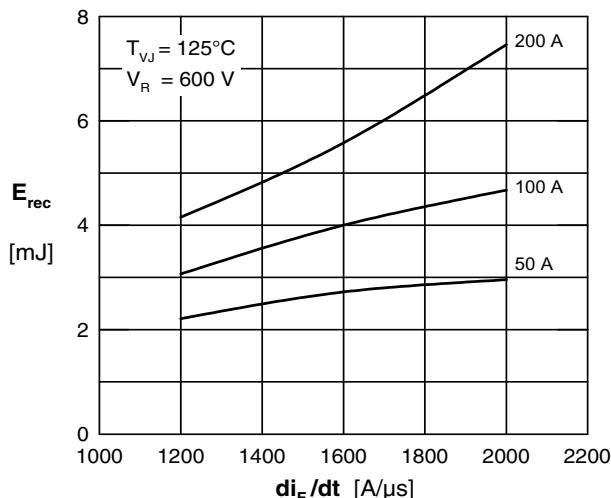
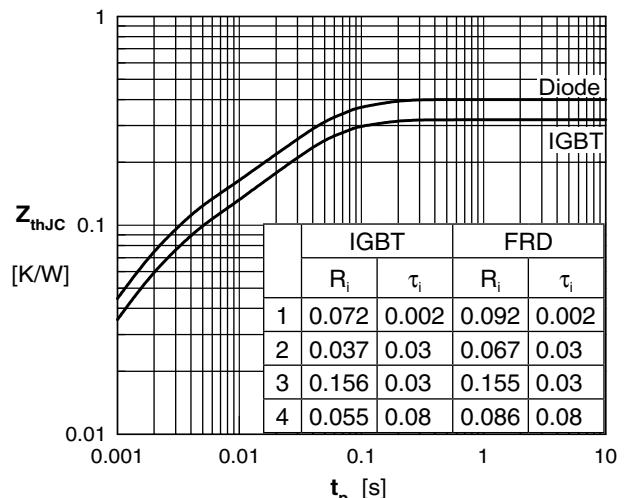
**Inverter D1 - D6**

 Fig. 7 Typ. Forward current versus V<sub>F</sub>

 Fig. 8 Typ. reverse recov.charge Q<sub>rr</sub> vs. di/dt

 Fig. 9 Typ. peak reverse current I<sub>RM</sub> vs. di/dt

 Fig. 10 Typ. recovery time t<sub>rr</sub> versus di/dt

 Fig. 11 Typ. recovery energy E<sub>rec</sub> versus di/dt


Fig. 12 Typ. transient thermal impedance